Search Note	eai	rc i	7 1	VC	ne	к
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,370	KAJIYA ET AL.	
Examiner	Art Unit	
Alix Elizabeth Echelmeyer	1745	

	SEAR	CHED	
Class	Subclass	Date	Examiner
429	188-246	8/20/2006	AE
29	623.1-623	8/20/2006	AE
423	591.2-594	8/20/2006	AE

INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search	8/19/2006	AE	
Searched EAST database, subclasses searched with text keywords	8/20/2006	AE	
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